

<b>Notice of References Cited</b>	Application/Control No. 10/672,357	Applicant(s)/Patent Under Reexamination FU ET AL.	
	Examiner Binh X. Tran	Art Unit 1765	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,967,171	11-2005	Fujimoto et al.	438/714
*	B	US-6,869,542	03-2005	Desphande et al.	216/51
*	C	US-6,833,325	12-2004	Huang et al.	438/714
*	D	US-6,730,454	05-2004	Pfeiffer et al.	430/270.1
*	E	US-6,080,680	06-2000	Lee et al.	438/727
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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